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PATENT

Docket No.: 12219/6

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANTS:

Hiroyuki NISHIDA

SERIAL NO.:

Unassigned

FILED

February 26, 2002

FOR

WAVEFRONT MEASURING APPARATUS AND WAVEFRONT

MEASURING METHOD

ASSISTANT COMMISSIONER FOR PATENTS

Washington D.C. 20231

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97

SIR:

In conformance with Applicants' duty of disclosure under 37 CFR §1.56(a) and §1.97(b), the references listed on the attached form PTO-1449 are hereby brought to the Examiner's attention.

In compliance with 37 C.F.R. §1.98, copies of the references are submitted herewith.

It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear in the "references cited" on any patent to issue therefrom.

Respectfully submitted,

Date: <u>February 26, 2002</u>

yonin C. Altmiller

Registration Number 25,951

KENYON & KENYON 1500 K Street, N.W., Suite 700 Washington, D.C. 200005-1257

Tel: 202.220-4200 Fax: 202.220-4201

INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY. DOCKET NO. 12219/6	SERIAL NO. O Unassigned
	APPLICANT Hir yuki NISHIDA	08355
	FILING DATE February 26, 2002	GROUP 101 Unassigned

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS/ SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT DAT		COUNTRY	CLASS/ SUBCLASS	TRANSLATION	
		DATE			YES	NO
	09-184787	07/15/97	Japan		ABS	
	10-090113	04/10/98	Japan		ABS	:

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
	·

EXAMINER	DATE CONSIDERED

EXAMINER: Initial if citation is considered, whether or not citation is in conformance with M.P.E.P. 609; strike out citation if not in conformance and not considered. Include copy of this form with next communication to applicant.